



Industrial Computing Platform Partner

ONYX-175X

Environment Test Report

Report NO: 09P020011

Issued by: Rex-Chang / 04/27/2009
Test Engineer Date

Reviewed by: Wenyuan Yang / 04/27/2009
Manager Date

Test item list

1. <i>Test item list</i> -----	2
2. <i>Temperature rise test</i> -----	3
3. <i>Temperature cycle operation test</i> -----	5
4. <i>High temperature storage test</i> -----	6
5. <i>Low temperature storage test</i> -----	7
6. <i>Humidity test</i> -----	8
7. <i>Cold start and hot start test</i> -----	9

Test Configuration:

Num	Item	Spec
1.	Panel PC:	ONYX-175X
	1. 17"LCD	CPT.CLAA170EA07.4 LAMP
	2. Inverter	HWAYOUN QF132V.1.16
	3. Power Board	AAEON PER-T070 A1.2
	4. Power Supply	FSP FSP180-50MP
	5. MSM Module	ATI E2400
2.	CPU Board:	COM-945 A1.0-A
	1. Bios Ver.	ONYX-175 A0.2
	2.CPU	Intel T7200 / Core 2 Duo 2.0GHz
	3.Memory	DSL 1GB / ELPIDA E5108AJBG-6E (DDR II 667)
	4. SATA II HDD (Wide Temp.)	Fujitsu MHY2080BH ESW / 80GB
	5.Test Software	Windows XP / Run PassMark Burn In Test 5.1 Pro

Temperature rise test

Test Date: 04-25-2009

Test Product: ONYX-175X

Test Site: AAEON QA Internal Lab.

Test Standard: Reference EN 61131-2(94), UL508 (94)

Temperature Measurement:

40 Channel Thermal Recorder:

YOKOGAWA Inc,

Model: DA100-13-1D

Date of Calibration: 12/13/08

Serial Number: 12A323190

Test Condition:

Ambient temperature: 40dC

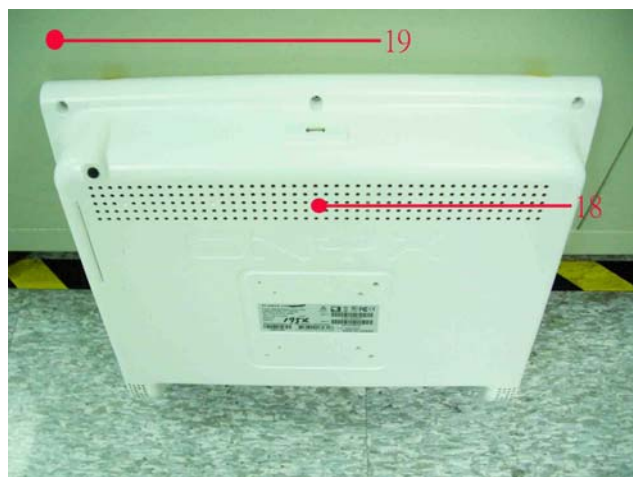
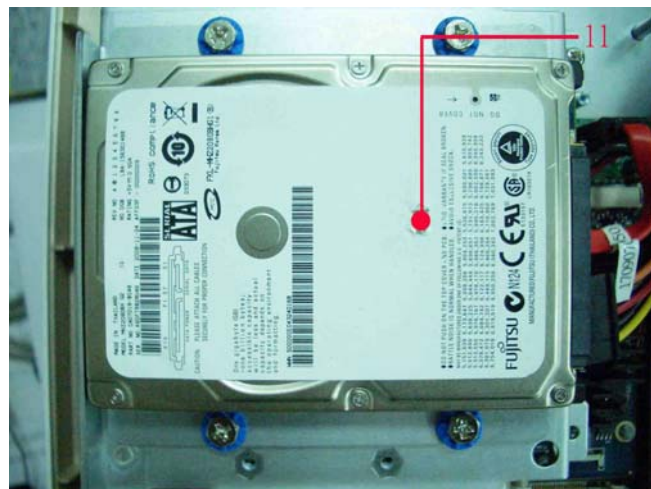
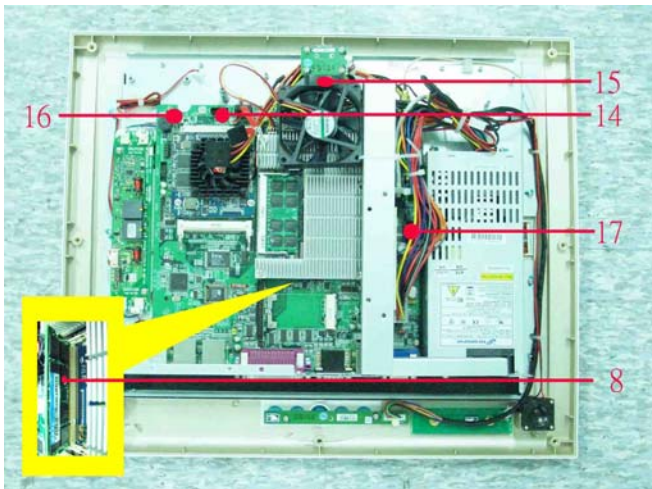
Continuous running till thermal stability (within less than 1°C)

Test Software:

Windows XP / Run PassMark Burn In Test 5.1 Pro

Terminal Recorder:

Measuring Thermal Couple Position :



Temperature rise test

Thermal profile data:

ONYX-175X

Point	Temp. Stage(°C)	Spec	40	25
COM-945				
1. INTEL Core 2 Duo / 2.0GHz CPU		100	84.5	69.5
2. U10 - (TF) .CLOCK GENERATOR.ICS.ICS954226AGLF		100	87.5	72.5
3. U3 - (TF) Intel 945GM Express.Intel.QG82945GM SL8Z2		99	88.1	73.1
4. U4 - (TF) ICH7M.Intel.NH82801GBM SL8YB		99	74.2	59.2
5. L24 - (TF) COIL.GOTREND.GSTC104P-R88MN		125	93.0	78.0
6. U25 - (TF) Supervisory Circuit.ANALOG DEVICES.ADM811SARTZ		125	73.7	58.7
7. U18 - (TF) Dual Power Supply Controller.SEMTECH.SC1485ITSTRT		100	91.7	76.7
8. Memory		95	94.0	79.0
PER-T070 I/O Board				
9. U15 - (TF) High Definition.Audio Codec.REALTEK.ALC888-GR		95	62.5	47.5
10. U6 - (TF) Audio Power Amplifier.TI.TPA0132PWP		110	62.8	47.8
11. HDD (Wide Temp.)		80	63.3	48.3
Inverter				
12. Q2		150	79.6	64.6
13. IC1		85	71.4	56.4
14. Control Box Inside Air Temperature - 1 (MSM Module)		N/A	67.8	52.8
15. Control Box Inside Air Temperature - 2		N/A	59.8	44.8
16. Control Box Inside Air Temperature - 3 (MSM Module)		N/A	63.8	48.8
17. Control Box Inside Air Temperature - 4 (Power Supply)		N/A	57.8	42.8
18. Control Box External Surface		N/A	56.2	41.2
19. Chamber Air Temperature		N/A	40.3	25.3
Any Tm value showed in red words which meaning the value over the Tc degree C of this device specification.				

Sample Configuration & Quantity Under Test:

Quantity: 1 (ONYX-175X)

Test Result:

No problem was found during the temperature rise operation test.

Temperature cycle test

Test Date: 04-10~12-2009

Test Product: ONYX-175X

Test Site: AAEON QA Internal Lab.

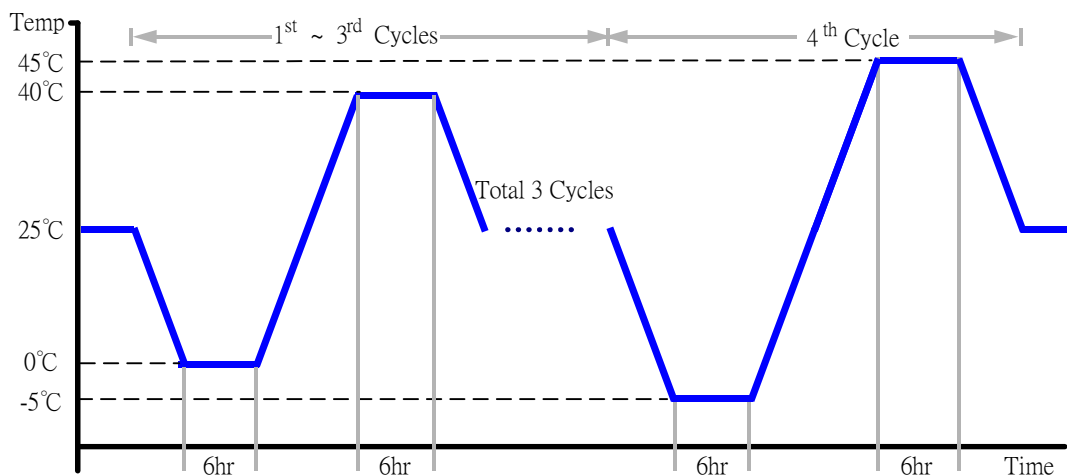
Test Standard: Reference IEC68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D7S-100+1 N2
Date of Calibration: 12/13/08
Serial Number: 3898

Test Condition:

1. Test Low Temperature: 0°C (1~3 cycles)
-5°C (4th cycle)
2. Test High Temperature: 40°C (1~3 cycles)
45°C (4th cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Software: Windows XP / Run PassMark Burn In Test 5.1 Pro
7. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (ONYX-175X)

Test Result:

No problem was found during the temperature cycle operation test.

Test Date: 04-12~14-2009

Test Product: ONYX-175X

Test Site: AAEON QA Internal Lab.

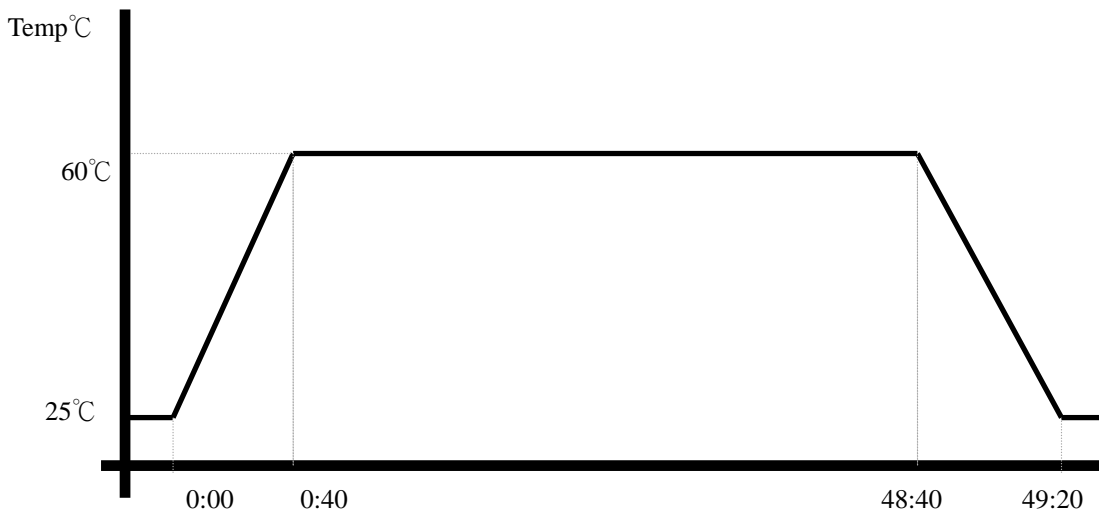
Test Standard: Reference IEC 68-2-2 Testing procedures
Test Bb: Dry Heat Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D7S-100+1 N2
Date of Calibration: 12/13/08
Serial Number: 3898

Testing Item:

1. Test Temperature: 60°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 5.1 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (ONYX-175X)

Test Result:

No problem was found after the high temperature storage test.

Low temperature storage test

Test Date: 04-14~16-2009

Test Product: ONYX-175X

Test Site: AAEON QA Internal Lab.

Test Standard: Reference IEC 68-2-1 Testing procedures
Test Ab: Cold Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D7S-100+1 N2
Date of Calibration: 12/13/08
Serial Number: 3898

Testing Item:

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 5.1 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:
Quantity: 1 (ONYX-175X)

Test Result:

No problem was found after the low temperature storage test.

Test Date: 04-16~19-2009

Test Product: ONYX-175X

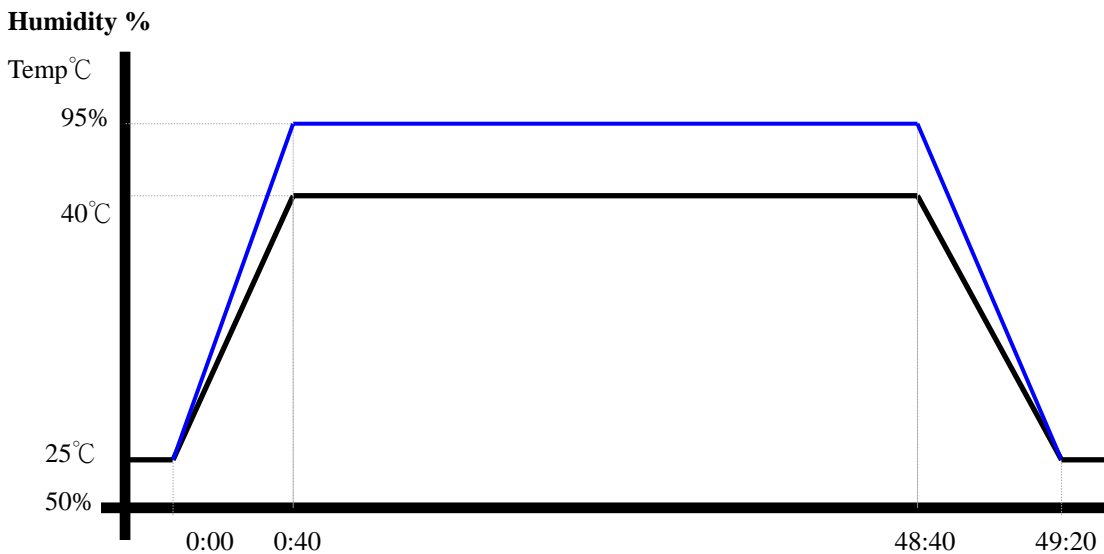
Test Site: AAEON QA Internal Lab.

Test Standard: Reference IEC 68-2-3 Testing procedures
Test Ca: Damp heat, steady state (Non-operation)

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D7S-100+1 N2
Date of Calibration: 12/13/08
Serial Number: 3898

Testing Item:

1. Test Temperature: 40°C
2. Test Humidity: 95%RH
3. Test Times: 48Hrs
4. Test Software: Windows XP / Run PassMark Burn In Test 5.1 Pro
5. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (ONYX-175X)

Test Result:

No problem was found after the humidity storage test.

Cold start and hot start test

Test Date: 04-08~09-2009

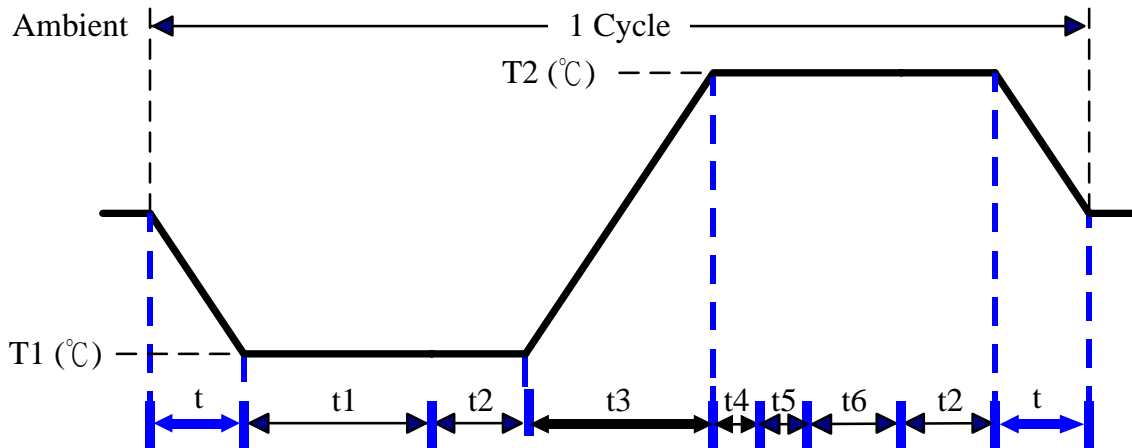
Test Product: ONYX-175X

Test Site: AAEON QA Internal Lab.

Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D7S-100+1 N2
Date of Calibration: 12/13/08
Serial Number: 3898

Test Condition:



Parameters	Description
T1	-5°C
T2	45°C
t1	4 hrs
t2, t6	2 hrs
t4, t5	1hrs
t, t3	2°C/min
n (Cycle)	1

t = temprature slope
t , t1, t6: Power Off
t2: Power on/off test 10 times (on 2 min / off 5min)
t3, t4: Run PassMark Burn In Test
t5: Win XP Software restart test 3 times
Test Software: Windows XP

Test Result:

- a. No problem was found during the cold start test.
- b. No problem was found during the hot start test.